Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination SHIMIZU ET AL.	
10/511,630		
Examiner	Art Unit	
Erin D. Chiem	2883	

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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(INCLUDING SEARCH	TES STRATEGY	)
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